



## **Description**

This P-Channel enhancement mode power FETs are produced with high cell density, DMOS trench technology, which is especially used to minimize on-state resistance. This device is particularly suited for low voltage application such as portable equipment, power management and other battery powered circuits, and low in-line power loss are needed in a very small outline surface mount package.

#### **Features**

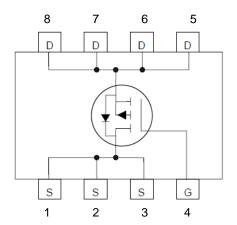
- VDS(V)=-30V, I<sub>D</sub>=-5.2A
- RDS(ON)= $51m\Omega$  @  $V_{GS}$ =-10V
- RDS(ON)= $68m\Omega$  @  $V_{GS}=-4.5V$
- High density cell design for low R<sub>DS(ON)</sub>

## **Absolute Maximum Ratings**

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Parameter			Max	Unit					
Drain-Source Voltage		$V_{DSS}$	-30	V					
Gate-Source Voltage		$V_{GSS}$	±20	V					
Drain Current (Note 1)	Continuous T <sub>A</sub> =25 °C		-5.2	Α					
	Pulsed (Note 2)	l <sub>D</sub>	-50						
Total Power Dissipation (Note 1)		P <sub>D</sub>	1.5	W					
Operating and Storage Temperature Range		$T_{J,}T_{STG}$	-55 to 150	οС					

# **Packaging Type**

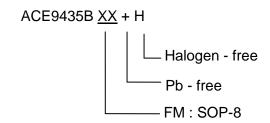
SOP-8







## **Ordering information**



## **Electrical Characteristics**

T<sub>A</sub>=25 °C unless otherwise noted

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit				
Off characteristics										
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}$ =0V, $I_D$ =-250uA	-30	-36		V				
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS}$ =-24V, $V_{GS}$ =0V		0.02	-1	uA				
Gate Leakage Current	I <sub>GSS</sub>	$V_{GS}=\pm20V$ , $V_{DS}=0V$		±1.5	±100	nA				
On characteristics										
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.6A		51	60	mΩ				
		$V_{GS}$ =-4.5V, $I_D$ =-2A		68	82					
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$ , $I_{D}=-250uA$	-1	-1.46	-3	V				
Forward Transconductance	<b>g</b> FS	$V_{DS}$ =-5V, $I_D$ =-6A		12		S				
	S	Switching								
Turn-On Delay Time	$T_{d(on)}$	$V_{DS}$ =-15V,R <sub>L</sub> =2.5 $\Omega$ R <sub>GEN</sub> =3 $\Omega$ , V <sub>GS</sub> =-10V		8.6		ns				
Turn-Off Delay Time	$t_{d(off)}$			28.2						
Dynamic Characteristics										
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V f=1MHz		550		pF				
Output Capacitance	C <sub>oss</sub>			60						
Reverse Transfer Capacitance	$C_{rss}$			50						
Drain-source diode characteristics and maximum ratings										
Diode Forward Voltage	V <sub>SD</sub>	$V_{GS}$ =0V, $I_{S}$ =-1A		-0.81		V				

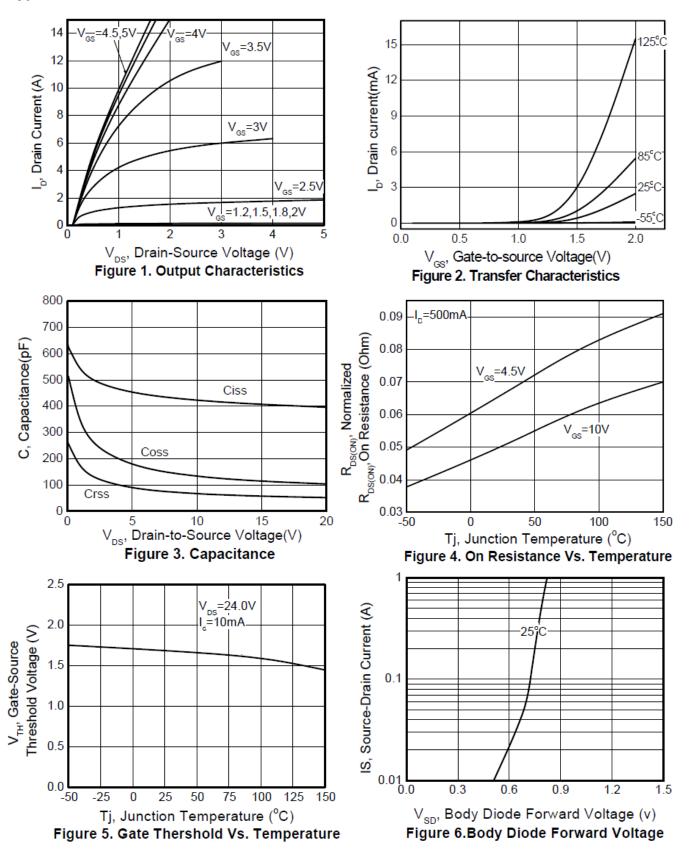
Note: 1. The value of  $P_D$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the DC thermal resistance rating.

2. Repetitive rating, pulse width limited by junction temperature.





# **Typical Performance Characteristics**

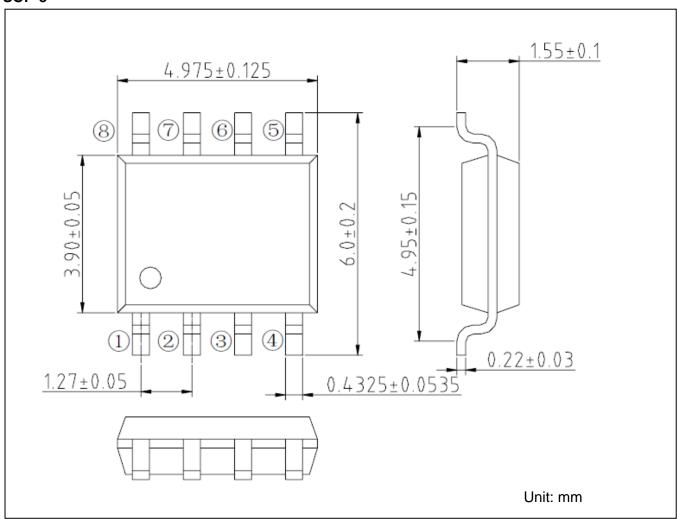






# **Packing Information**

# SOP-8





# **ACE9435B**

#### P-Channel Enhancement Mode Field Effect Transistor

#### Notes

ACE does not assume any responsibility for use as critical components in life support devices or systems without the express written approval of the president and general counsel of ACE Electronics Co., LTD. As sued herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and shoes failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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